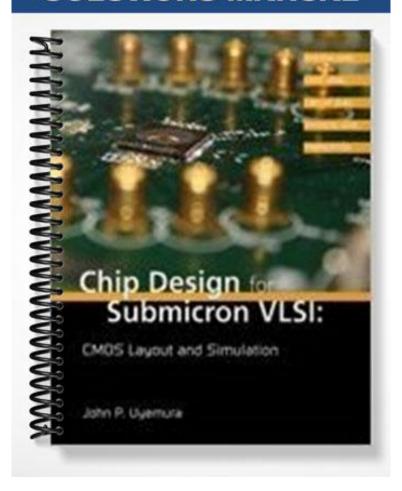
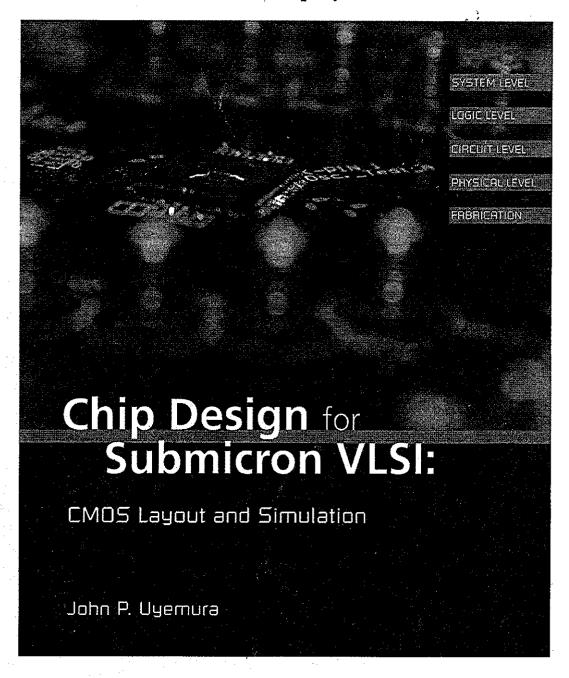
SOLUTIONS MANUAL



INSTRUCTOR'S SOLUTIONS MANUAL

to accompany



ISBN 0-534-46631-1 JOHN P. UYEMURA







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Chapter 2 Views of a Chip—Layers and Patterns

Exercise 2.1

Applying Equation (2-11) from the textbook we get:

$$\tau_o = B l_o^2$$

$$(a) l = 2l_o$$

$$\tau_a = B(2l_o^2) = 4\tau_o$$

$$(b) l = 4l_o$$

$$\tau_a = B(4l_o^2) = 16\tau_c$$

$$(c) l = 8l_o$$

$$\tau_a = B(8l_o^2) = 64\tau_o$$

The delay increases with the square of the length.

Exercise 2.2

The line resistance R is computed from Equations (2.1) and (2.2)

$$R = \frac{\rho l}{A} \Omega$$

$$V_{XY} = iR$$

(2.2)

where $\rho=1.8\mu\Omega$ -cm, $l=25\mu$ m, $w=0.6\mu$ m, $t=0.25\mu$ m. We find, after converting into cm, that R=3.0 Ω .

(a)
$$R = \frac{(1.8 \times 10^{-6})(25 \times 10^{-4})}{(0.6 \times 10^{-4})(0.25 \times 10^{-4})} = 3\Omega$$

(b) The line capacitance C is computed from Equation (2.3)

$$C \approx \frac{\varepsilon_{\rm ins}\omega l}{t_{\rm ins}}$$
 Farads (F) (2.3)

(b) The line capacitance C is computed from equations (2.3), with ϵ_{ins} =3.54x10⁻¹³ F/cm. We find, C=0.37x10⁻¹⁵ F=0.37 fF (femto-Farad).

Exercise 2.3

- (a) Applying Equation (2.14), the electron density n is almost equivalent to N_d , so $n=2\times10^{18}~cm^{-3}$
- (b) The resistively of the region is obtained from Equation (2.18) as we consider it an n-type region.

$$p = \frac{1}{(1.6 \times 10^{-19})(125)(2 \times 10^{18})} = 0.025 \Omega cm$$

or $\rho_n=0.025\Omega$ -cm

(c) By applying Eq. (2.1) and (2.2), the resistance of the patterned line is: $R=26.6K\Omega$

The resistance value is very high as the electron concentration is quite low $(2x10^{18})$ cm⁻³ corresponding to the characteristics present in n-well regions.

Exercise 2.4

(a) Applying Equation (2.16), the hole density π is almost equivalent to N_a , so

$$p \approx N_A = 2 \times 10^{17} cm^{-3}$$

$$p = \frac{1}{(1.6 \times 10^{-19})(80)(2 \times 10^{17})} = 0.391\Omega cm$$

(b) The resistance of the patterned line is:

(c)
$$R = \frac{(0.391)(9.6\mu)}{(0.3\mu)(0.15\mu)} = 83.4M\Omega$$